

Notice of References Cited	Application/Control No. 10/798,469	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner VanThu Nguyen	Art Unit 2824	Page 1 of 1

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*	B	US-6,519,192 B2	02-2003	Ooishi, Tsukasa	365/200
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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